

40V N-CHANNEL ENHANCEMENT MODE MOSFET

MAIN CHARACTERISTICS

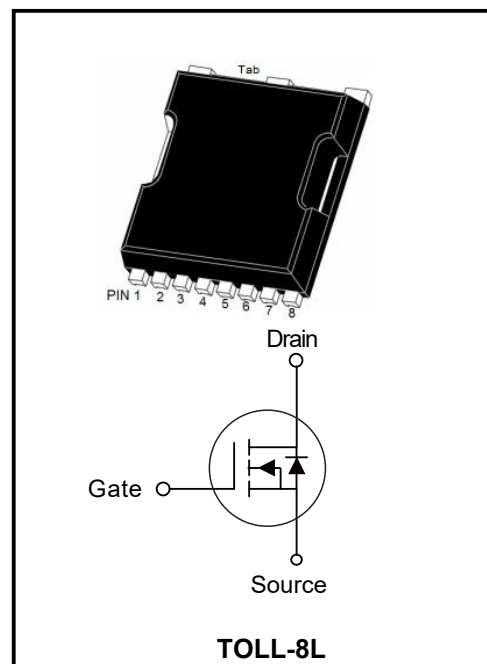
I_D	200A
V_{DSS}	40V
$R_{DS(on)-typ}(@V_{GS}=10V)$	< 2.5mΩ (Type: 1.9 mΩ)

Features

◆ YFW-SGT technology

Application

◆ BMS
◆ BLDC
◆ UPS



Maximum Ratings at $T_c=25^\circ\text{C}$ unless otherwise specified

Characteristics	Symbols	Value	Units
Drain-Source Voltage	V_{DS}	40	V
Gate - Source Voltage	V_{GS}	± 20	V
Continuous Drain Current, $V_{GS} @ 10V^1$ @ $T_c=25^\circ\text{C}$	I_D	200	A
Continuous Drain Current, $V_{GS} @ 10V^1$ @ $T_c=100^\circ\text{C}$	I_D	130	A
Pulsed Drain Current	I_{DM}	600	A
Single Pulse Avalanche Energy	E_{AS}	525	mJ
Avalanche Current	I_{AS}	35	A
Power Dissipation @ $T_c=25^\circ\text{C}$	P_D	130	W
Thermal Resistance Junction-ambient ¹	$R_{\theta JA}$	35	$^\circ\text{C/W}$
Thermal Resistance Junction-Case	$R_{\theta JC}$	1.5	$^\circ\text{C/W}$
Operating Junction Temperature Range	T_J	-55 to +150	$^\circ\text{C}$
Storage Temperature Range	T_{STG}	-55 to +150	$^\circ\text{C}$

Maximum Ratings at Tc=25°C unless otherwise specified

Characteristics	Test Condition	Symbols	Min	Typ	Max	Units
Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250uA	V(BR)DSS	40	47	-	V
Zero Gate Voltage Drain Current	V _{DS} =40V , V _{GS} =0V	I _{DSS}	-	-	1.0	μA
Gate to Body Leakage Current	V _{GS} =±20V, V _{DS} =0V	I _{GSS}	-	-	±100	nA
Gate -Threshold Voltage	V _{DS} =V _{GS} , I _D =250uA	V _{GS(th)}	1.0	1.5	2.5	V
Static Drain-Source on-Resistance	V _{GS} =10V, I _D =30A	R _{DS(ON)}	-	1.9	2.5	mΩ
	V _{GS} =4.5V, I _D =20A		-	2.7	4.0	
Input Capacitance	V _{DS} =20V V _{GS} =0V f=1.0MHz	C _{iss}	-	3162	-	pF
Output Capacitance		C _{oss}	-	1099	-	
Reverse Transfer Capacitance		C _{rss}	-	157	-	
Total Gate Charge	V _{DS} =20V V _{GS} =10V I _D =75A	Q _g	-	95	-	nC
Gate-Source Charge		Q _{gs}	-	15	-	
Gate-Drain(“Miller”) Charge		Q _{gd}	-	11	-	
Turn-on delay time	V _{DD} =20V I _D =75A R _G =1.6Ω V _{GS} =10V	t _{d(on)}	-	12.5	-	ns
Turn-on Rise Time		T _r	-	7	-	
Turn-Off Delay Time		t _{d(OFF)}	-	50	-	
Turn-Off Fall Time		t _f	-	8.5	-	
Maximum Continuous Drain to Source Diode Forward Current		I _S	-	-	140	A
Maximum Pulsed Drain to Source Diode Forward Current		I _{SM}	-	-	560	A
Drain to Source Diode Forward Voltage	V _{GS} =0V , I _S =30A	V _{SD}	-	-	1.2	V
Body Diode Reverse Recovery Time	T _J =25℃,I _F =I _S , dI/dt=100A /μs	t _{rr}	-	31	-	ns
Body Diode Reverse Recovery Charge		Q _{rr}	-	110	-	nC

Note :

- 1、The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
- 2、The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
- 3、The EAS data shows Max. rating . The test condition is $V_{DD}=32V, V_{GS}=10V, L=0.1mH, I_{AS}=35A$
- 4、The power dissipation is limited by 150°C junction temperature
- 5、The data is theoretically the same as I D and I DM , in real applications , should be limited by total power dissipation.

Ratings and Characteristic Curves

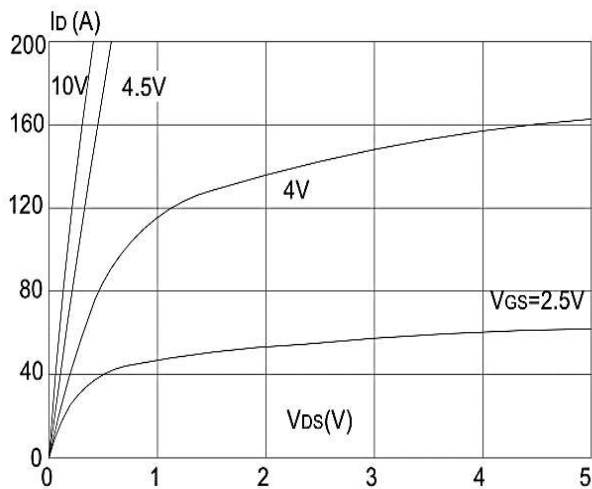


Figure1: Output Characteristics

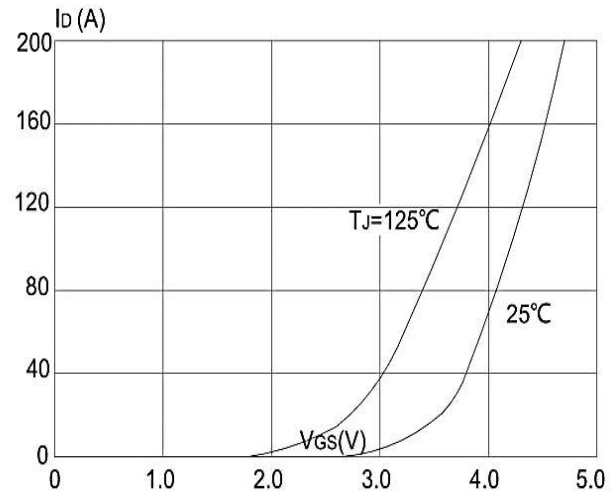


Figure 2: Typical Transfer Characteristics

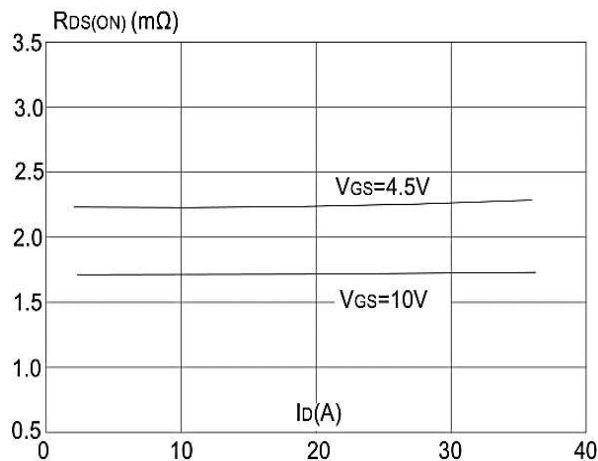


Figure 3: On-resistance vs. Drain Current

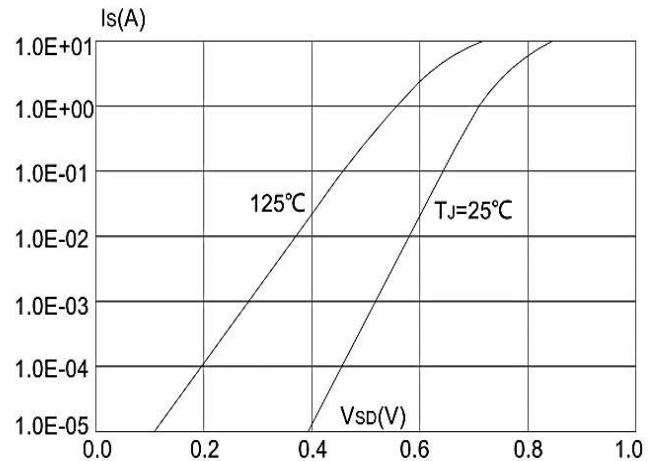


Figure 4: Body Diode Characteristics

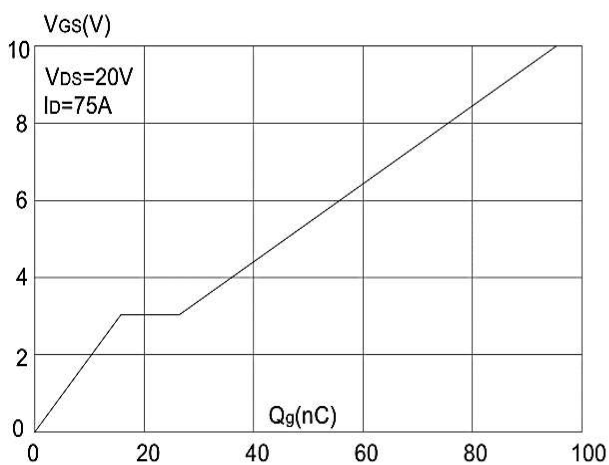


Figure 5: Gate Charge Characteristics

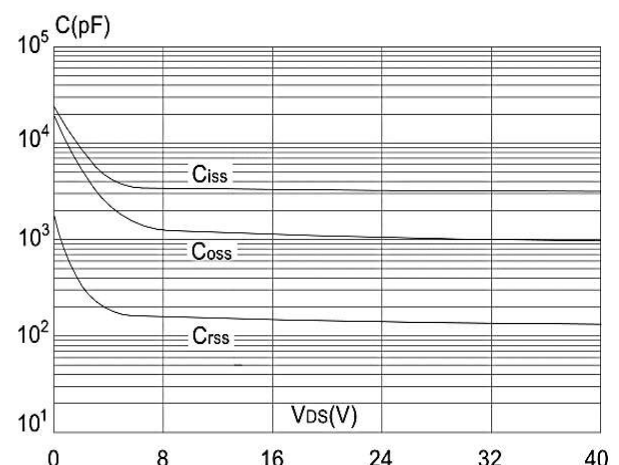


Figure 6: Capacitance Characteristics

Ratings and Characteristic Curves

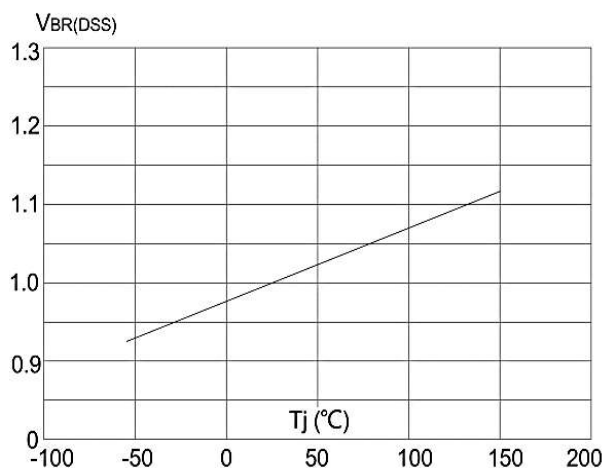


Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

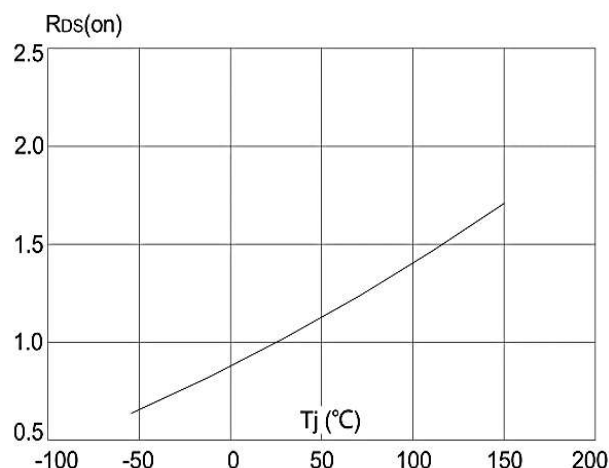


Figure 8: Normalized on Resistance vs. Junction Temperature

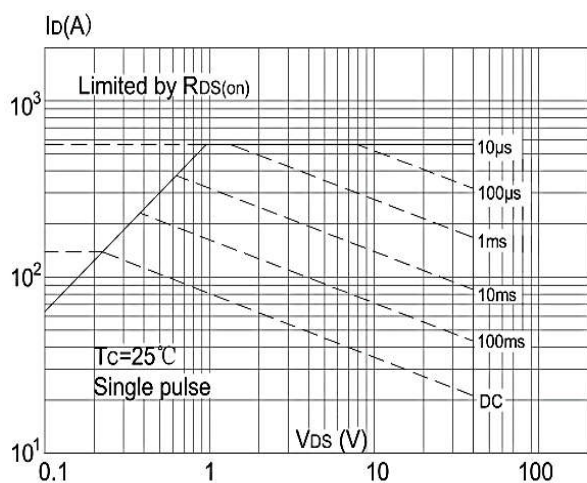


Figure 9: Maximum Safe Operating Area

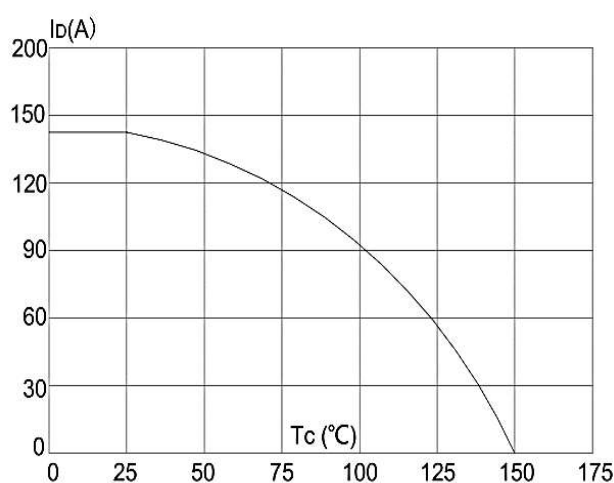


Figure 10: Maximum Continuous Drain Current vs. Case Temperature

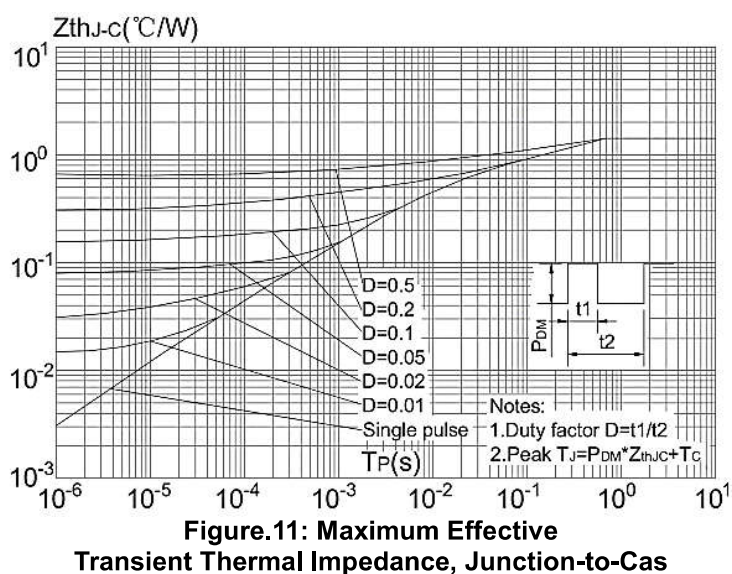
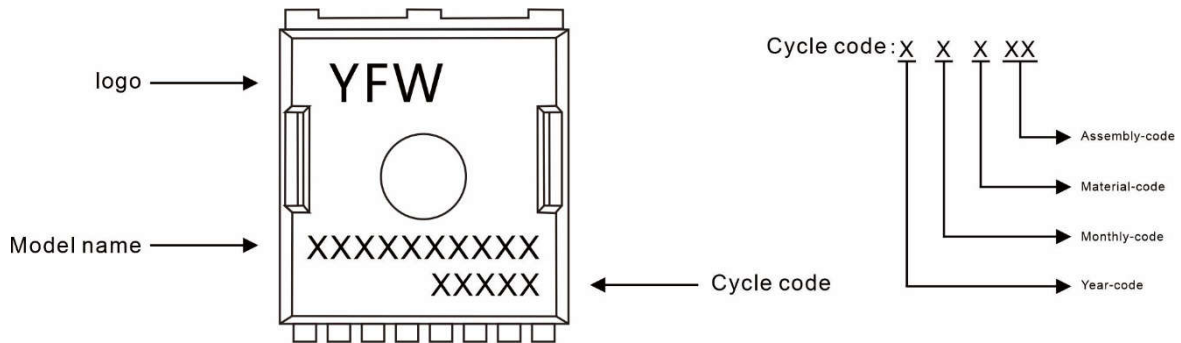


Figure 11: Maximum Effective Transient Thermal Impedance, Junction-to-Cas

Marking Diagram



Ordering information

Model name	Package	Unit Weight	Base Quantity	Packing Quantity
YFWG200N04TL	TOLL-8L	-	2000pcs/reel	4000pcs/box 20000pcs/Cartron

Package Dimensions

TOLL-8L

Dim	Millimeter		Inches	
	Min.	Max.	Min.	Max.
A	2.20	2.40	0.087	0.095
b	0.70	0.90	0.028	0.035
b1	9.70	9.90	0.382	0.390
b2	0.42	0.50	0.017	0.020
c	0.40	0.60	0.016	0.024
D	10.28	10.58	0.405	0.417
D2	3.10	3.50	0.122	0.138
E	9.70	10.10	0.382	0.398
E1	7.90	8.30	0.311	0.327
e	1.20BSC		0.047BSC	
H	11.48	11.88	0.452	0.468
H1	6.75	7.15	0.266	0.281
N	8		0.315	
J	3.00	3.30	0.118	0.130
K1	3.98	4.38	0.157	0.172
L	1.40	1.80	0.055	0.071
L1	0.60	0.80	0.024	0.032
L2	0.50	0.70	0.020	0.028
L4	1.00	1.30	0.04	0.051
θ	4°	10°	4°	10°

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